

# NP34N055HLE, NP34N055ILE

# SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

### DESCRIPTION

These products are N-Channel MOS Field Effect Transistors designed for high current switching applications.

# FEATURES

- Channel temperature 175 degree rated
- Super low on-state resistance  $R_{DS(on)1} = 18 \text{ m}\Omega \text{ MAX.}$  (VGs = 10 V, ID = 17 A)  $R_{DS(on)2} = 22 \text{ m}\Omega \text{ MAX.}$  (VGs = 5 V, ID = 17 A)
- Low Ciss : Ciss = 2000 pF TYP.
- Built-in gate protection diode

# ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

	-			
Drain to Source Voltage	VDSS	55	V	
Gate to Source Voltage	Vgss	±20	V	
Drain Current (DC)	D(DC)	±34	А	
Drain Current (Pulse) <sup>Note1</sup>	D(pulse)	±136	А	
Total Power Dissipation (T <sub>A</sub> = 25 °C)	Рт	1.2	W	
Total Power Dissipation (Tc = 25 °C)	Р⊤	88	W	
Single Avalanche Current Note2	las	34 / 27 / 10	А	
Single Avalanche Energy <sup>Note2</sup>	Eas	11 / 72 / 100	mJ	
Channel Temperature	Tch	175	°C	
Storage Temperature	Tstg	–55 to + 175	°C	

#### **ORDERING INFORMATION**

PART NUMBER	PACKAGE	
NP34N055HLE	TO-251	
NP34N055ILE	TO-252	

(TO-251)

(TO-252)



#### **Notes 1.** PW $\leq$ 10 $\mu$ s, Duty cycle $\leq$ 1 %

**2.** Starting  $T_{ch} = 25 \text{ °C}$ ,  $R_G = 25 \Omega$ ,  $V_{GS} = 20 \text{ V} \rightarrow 0 \text{ V}$  (see Figure 4.)

#### THERMAL RESISTANCE

*	Channel to Case	Rth(ch-C)	1.70	°C/W
	Channel to Ambient	Rth(ch-A)	125	°C/W

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# \* ELECTRICAL CHARACTERISTICS (TA = 25 °C)

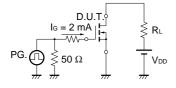
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, Id = 17 A		14	18	mΩ
	RDS(on)2	Vgs = 5 V, Id = 17 A		17	22	mΩ
	RDS(on)3	Vgs = 4.5 V, Id = 17 A		18	24	mΩ
Gate to Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , ID = 250 $\mu$ A	1.5	2	2.5	V
Forward Transfer Admittance	y <sub>fs</sub>	Vds = 10 V, Id = 17 A	9	19		S
Drain Leakage Current	IDSS	Vds = 55 V, Vgs = 0 V			10	μA
Gate to Source Leakage Current	lgss	$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA
Input Capacitance	Ciss	V <sub>DS</sub> = 25 V		2000	3000	pF
Output Capacitance	Coss	Vgs = 0 V		250	380	pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		130	230	pF
Turn-on Delay Time	td(on)	ID = 17 A		17	37	ns
Rise Time	tr	$V_{GS(on)} = 10 V$		11	28	ns
Turn-off Delay Time	td(off)	Vdd = 28 V		57	110	ns
Fall Time	tr	R <sub>G</sub> = 1 Ω		9	23	ns
Total Gate Charge	Q <sub>G1</sub>	$I_D = 34 \text{ A}, V_{DD} = 44 \text{ V}, V_{GS(on)} = 10 \text{ V}$		41	72	nC
	Q <sub>G2</sub>	ID = 34 A		23	35	nC
Gate to Source Charge	QGS	Vdd = 44 V		7		nC
Gate to Drain Charge	Qgd	Vgs = 5 V		12		nC
Body Diode Forward Voltage	VF(S-D)	IF = 34 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 34 A, VGS = 0 V		42		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/µs		58		nC

# TEST CIRCUIT 1 AVALANCHE CAPABILITY

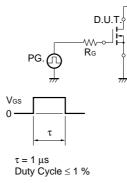
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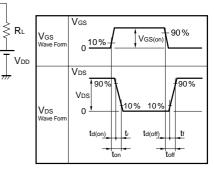
-Starting Tch

#### **TEST CIRCUIT 3 GATE CHARGE**

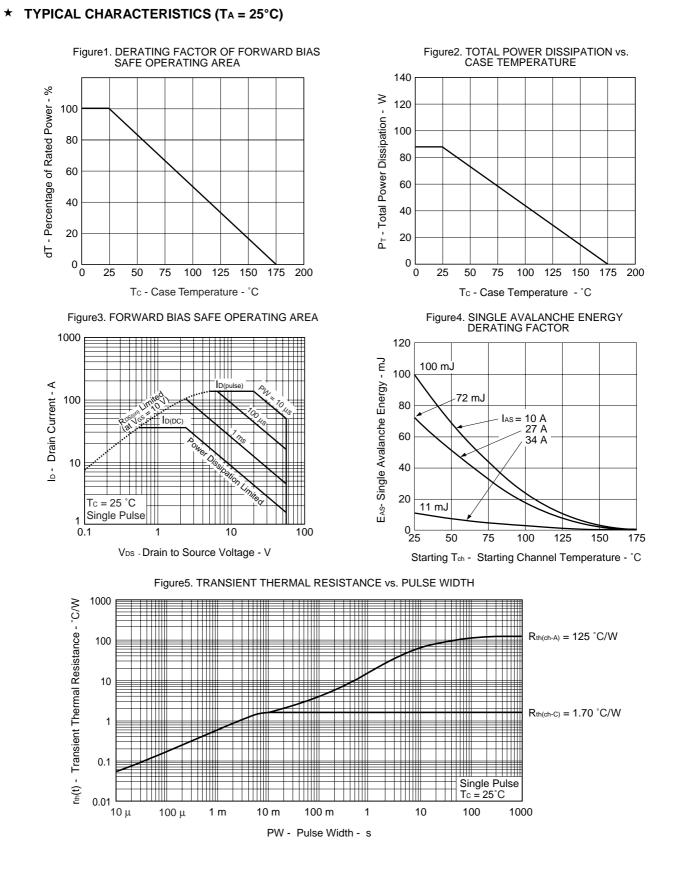


#### **TEST CIRCUIT 2 SWITCHING TIME**

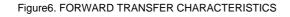




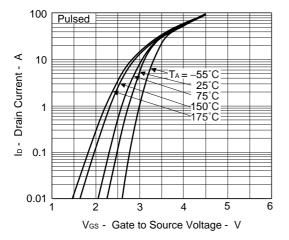
Data Sheet D14154EJ2V0DS00



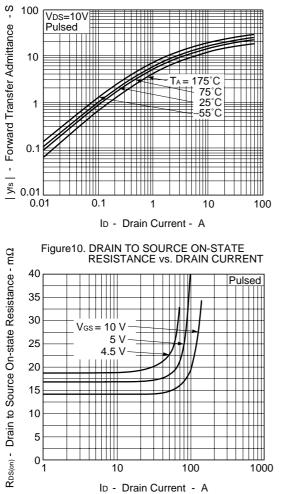
Data Sheet D14154EJ2V0DS00

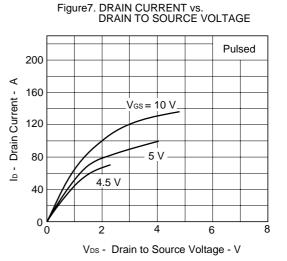


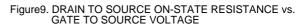
NEC

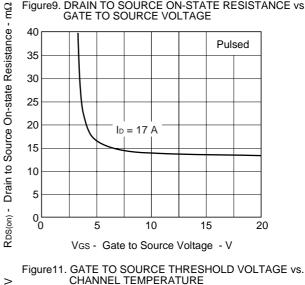


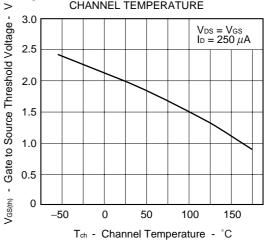




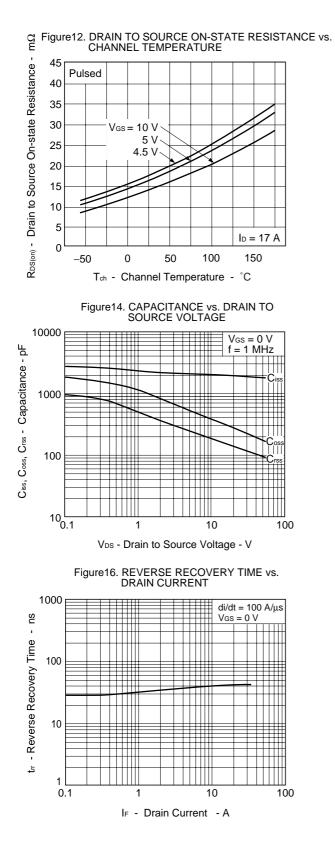






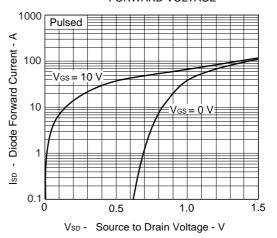


#### Data Sheet D14154EJ2V0DS00

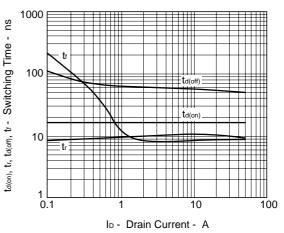


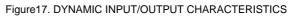
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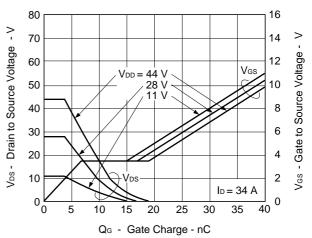
# Figure 13. SOURCE TO DRAIN DIODE FORWARD VOLTAGE





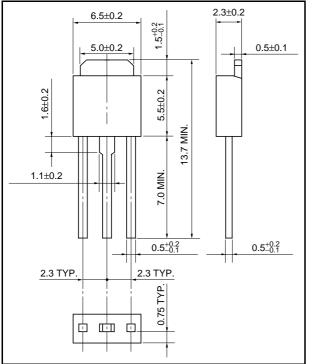


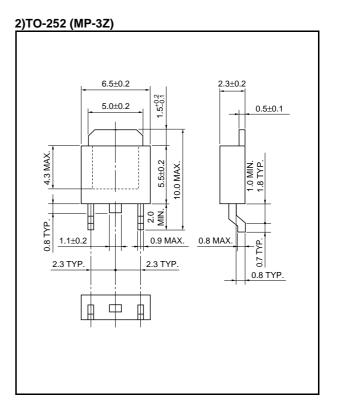




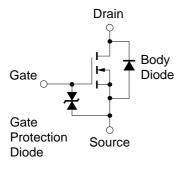
### PACKAGE DRAWINGS (Unit : mm)

#### 1)TO-251 (MP-3)





#### **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

[MEMO]

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